## HiPerFRED ${ }^{\text {TM }}$ Epitaxial Diode with soft recovery

## Preliminary Data

| $V_{\text {RSM }}$ <br> $V$ | $V_{\text {RRM }}$ <br> $V$ | Type |
| :--- | :---: | :--- |
| 200 | 200 | DSEP 8-02A |



Symbol
Test Conditions
Maximum Ratings


| Symbol | Test Conditions | Characteristic Values typ. ${ }^{\text {max. }}$ |  |  |
| :---: | :---: | :---: | :---: | :---: |
| $\mathrm{I}_{\mathrm{R}} \quad$ (1) | $\begin{array}{ll} \mathrm{T}_{\mathrm{VJ}}=25^{\circ} \mathrm{C} \quad \mathrm{~V}_{\mathrm{R}}=\mathrm{V}_{\mathrm{RRM}} \\ \mathrm{~T}_{\mathrm{VJ}}=150^{\circ} \mathrm{C} \quad \mathrm{~V}_{\mathrm{R}}=\mathrm{V}_{\mathrm{RR}} \mathrm{M} \end{array}$ |  | $\begin{aligned} & 50 \\ & 0.2 \end{aligned}$ | $\begin{gathered} \mu \mathrm{A} \\ \mathrm{~mA} \end{gathered}$ |
| $\mathrm{V}_{\mathrm{F}}$ (2) | $\begin{aligned} \mathrm{I}_{\mathrm{F}}=8 \mathrm{~A} ; \quad \mathrm{T}_{\mathrm{V} /} & =150^{\circ} \mathrm{C} \\ T_{V j} & =25^{\circ} \mathrm{C} \end{aligned}$ |  | $\begin{aligned} & 0.94 \\ & 1.30 \end{aligned}$ | $\begin{aligned} & \mathrm{V} \\ & \mathrm{~V} \end{aligned}$ |
| $\begin{aligned} & \overline{\mathbf{R}_{\mathrm{thJC}}} \\ & \mathbf{R}_{\mathrm{thcH}} \end{aligned}$ |  | 0.5 | 2.5 | $\begin{aligned} & \text { K/W } \\ & \text { K/W } \end{aligned}$ |
| $\mathrm{trr}_{\text {r }}$ | $\begin{aligned} & \mathrm{I}_{\mathrm{F}}=1 \mathrm{~A} ;-\mathrm{di} / \mathrm{dt}=50 \mathrm{~A} / \mu \mathrm{s} ; \\ & \mathrm{V}_{\mathrm{R}}=30 \mathrm{~V} ; \mathrm{T}_{\mathrm{VJ}}=25^{\circ} \mathrm{C} \end{aligned}$ | 25 |  | ns |
| $\mathrm{I}_{\mathrm{RM}}$ | $\begin{aligned} & \mathrm{V}_{\mathrm{R}}=100 \mathrm{~V} ; \mathrm{I}_{\mathrm{F}}=10 \mathrm{~A} ;-\mathrm{di} / \mathrm{dt}=100 \mathrm{~A} / \mu \mathrm{S} \\ & \mathrm{~T}_{\mathrm{V},}=100^{\circ} \mathrm{C} \end{aligned}$ |  | 4.1 | A |

$\mathrm{I}_{\text {FAV }}=8 \mathrm{~A}$
$\mathrm{~V}_{\text {RRM }}=200 \mathrm{~V}$
$\mathrm{t}_{\mathrm{rr}}=25 \mathrm{~ns}$

## TO-220 AC



A $=$ Anode,$C=$ Cathode,$T A B=$ Cathode

## Features

- International standard package
- Planar passivated chips

Very short recovery time

- Extremely low switching losses
- Low $\mathrm{I}_{\mathrm{Rm}}$-values
- Soft recovery behaviour
- Epoxy meets UL 94V-0


## Applications

- Antiparallel diode for high frequency switching devices
- Antisaturation diode
- Snubber diode
- Free wheeling diode in converters and motor control circuits
- Rectifiers in switch mode power supplies (SMPS)
- Inductive heating
- Uninterruptible power supplies (UPS)
- Ultrasonic cleaners and welders


## Advantages

- Avalanche voltage rated for reliable operation
- Soft reverse recovery for low EMI/RFI
- Low $I_{\text {RM }}$ reduces:
- Power dissipation within the diode
- Turn-onloss inthe commutating switch


## Dimensions see Outlines.pdf

Pulse test: (1) Pulse Width = 5 ms , Duty Cycle $<2.0 \%$
(2) Pulse Width $=300 \mu \mathrm{~s}$, Duty Cycle $<2.0 \%$

Data according to IEC 60747 and per diode unless otherwise specified
IXYS reserves the right to change limits, test conditions and dimensions.

